

DIELECTRIC PROPERTIES OF ATiO_3 CERAMICS (A=Ca, Sr, Ba) SINTERED WITH 5 Mol. % OF LiF AND CaF_2

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Topic A: Dielectric, piezoelectric and ferroelectric materials

The spectacular development in new technologies of information and communication (NTIC) during the last decade has tremendously urged the research in engineering ceramics. The perovskite-type family ABO_3 and, specifically the titanates ATiO_3 , attracted more and more scientists worldwide because of their large area of applications. Among ATiO_3 ceramics, CaTiO_3 (CTO), SrTiO_3 (STO) and BaTiO_3 (BTO) became the key materials post-PZT. The aim of the present work is the comparison of the dielectric properties of CTO, STO and BTO sintered with 5 mol. % of $(\text{LiF} + \text{CaF}_2)$.

CTO, STO and BTO were previously synthesized by calcination of stoichiometric amounts of ACO_3 (A = Ca, Sr, Ba) and TiO_2 . 95 mol. % of the prepared ATO powders were mixed with 5 mol. % of $(\text{LiF} + \text{CaF}_2)$ then wet-ground in ethanol. These mixtures were cold-pressed into pellets and air-fired at 1000 ° C for 2 h. The ceramics thus obtained were investigated by X-ray diffraction (XRD) and scanning electron microscopy (SEM). Dielectric measurements (DE) were carried out from 100 K up to 500 K in the frequency range $10^2 \text{ Hz} - 4 \times 10^7 \text{ Hz}$.

As results, the XRD patterns show each sample to be a perovskite single phase. In comparison with ATO, the fluorinated ceramics show compact microstructures. The shrinkages $\Delta\Phi/\Phi$ are in the range 13 – 22 %. The oxyfluoride deriving from CTO exhibits a sharp peak of ϵ_r and $\tan\delta$ around 10 ° C. For STO, no phase transition is detected in the temperature range investigated. On the other hand, the ceramic related to BTO displays a broad maximum of the dielectric permittivity ϵ_r and a minimum of the dielectric losses $\tan\delta$ at the ferroelectric Curie temperature $T_C \sim 20$ ° C. Moreover, a dielectric relaxation is observed at about 10 MHz. These oxyfluoride ceramics could be of interest for capacitors manufacturing.

Keywords: ATiO_3 perovskite; Oxyfluoride; Ceramics; Dielectric properties.